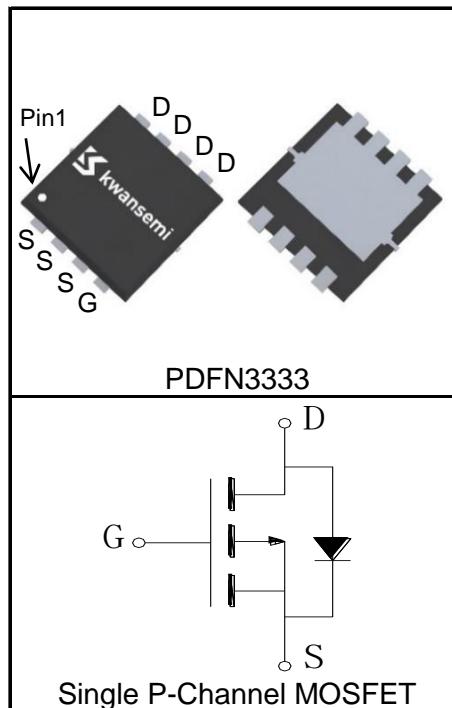


Features

- -20V/-45A
- $R_{DS\ (ON)} = 8.3\text{m}\Omega$ (Typ.)@ $V_{GS}=-4.5\text{V}$
- $R_{DS\ (ON)} = 11\text{m}\Omega$ (Typ.)@ $V_{GS}=-2.5\text{V}$
- $R_{DS\ (ON)} = 15\text{m}\Omega$ (Typ.)@ $V_{GS}=-1.8\text{V}$
- Low $R_{DS\ (ON)}$
- Super High Dense Cell Design
- Fast Switching Speed
- 100% avalanche tested

Pin Description



Applications

- Switching Application Systems



Halogen-Free

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
Common Ratings ($T_c=25^\circ\text{C}$ Unless Otherwise Noted)			
V_{DSS}	Drain-Source Voltage	-20	V
V_{GSS}	Gate-Source Voltage	± 12	
T_{Jmax}	Maximum Junction Temperature	150	$^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to 150	$^\circ\text{C}$
I_s	Diode Continuous Forward Current	$T_c=25^\circ\text{C}$	-45
			A

Mounted on Large Heat Sink

$I_{DP}^{(1)}$	Pulse Drain Current	$T_c=25^\circ\text{C}$	-180	A
$I_D^{(2)}$	Continuous Drain Current@ $T_c(V_{GS}=-4.5\text{V})$	$T_c=25^\circ\text{C}$	-45	A
		$T_c=100^\circ\text{C}$	-28	
	Continuous Drain Current@ $T_A(V_{GS}=-4.5\text{V})^{(3)}$	$T_A=25^\circ\text{C}$	-15	
		$T_A=70^\circ\text{C}$	-12	
P_D	Maximum Power Dissipation@ T_c	$T_c=25^\circ\text{C}$	30	W
		$T_c=100^\circ\text{C}$	12	
	Maximum Power Dissipation@ T_A ⁽³⁾	$T_A=25^\circ\text{C}$	3.5	
		$T_A=70^\circ\text{C}$	2.3	

Symbol	Parameter	Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	4.1	°C/W
$R_{\theta JA}^{(3)}$	Thermal Resistance-Junction to Ambient	35	°C/W
Drain-Source Avalanche Ratings			
$E_{AS}^{(4)}$	Avalanche Energy, Single Pulsed	64	mJ

Electrical Characteristics ($T_C=25^\circ C$ Unless Otherwise Noted)

Symbol	Parameter	Test Condition	KS2317MA			Unit
			Min.	Typ.	Max.	

Static Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_{DS}=-250\mu A$	-20			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-20V, V_{GS}=0V$			-1	μA
		$T_J=125^\circ C$			-30	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=-250\mu A$	-0.4	-0.7	-1	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 12V, V_{DS}=0V$			± 100	nA
$R_{DS(ON)}^{(5)}$	Drain-Source On-state Resistance	$V_{GS}=-4.5V, I_{DS}=-10A$		8.3	10	mΩ
		$V_{GS}=-2.5V, I_{DS}=-8A$		11	15	mΩ
		$V_{GS}=-1.8V, I_{DS}=-6A$		15	20	mΩ

Diode Characteristics

$V_{SD}^{(5)}$	Diode Forward Voltage	$I_{SD}=-10A, V_{GS}=0V$		-0.83	-1.2	V
t_{rr}	Reverse Recovery Time			36		ns
Q_{rr}	Reverse Recovery Charge	$I_{SD}=-10A, dI_{SD}/dt=100A/\mu s$		127		nC

Dynamic Characteristics⁽⁶⁾

R_G	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, F=1.0MHz$		8.5		Ω
C_{iss}	Input Capacitance	$V_{GS}=0V,$ $V_{DS}=-10V,$ Frequency=1MHz		2550		pF
C_{oss}	Output Capacitance			310		
C_{rss}	Reverse Transfer Capacitance			265		
$t_{d(ON)}$	Turn-on Delay Time			23		ns
t_r	Turn-on Rise Time	$V_{DD}=-10V, I_{DS}=-10A,$ $V_{GS}=-4.5V, R_G=3\Omega$		31		
$t_{d(OFF)}$	Turn-off Delay Time			50		
t_f	Turn-off Fall Time			29		

Gate Charge Characteristics⁽⁶⁾

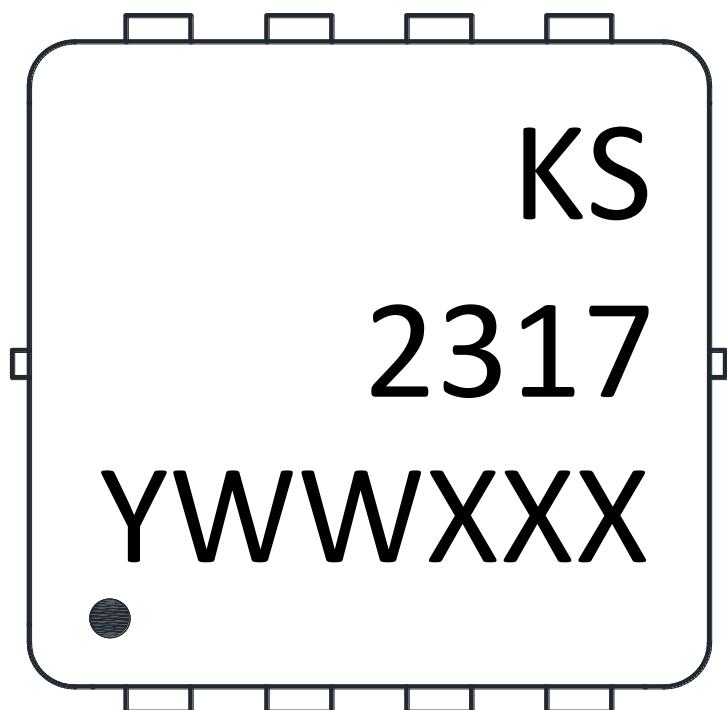
Q_g	Total Gate Charge	$V_{DS}=-10V, V_{GS}=-4.5V,$ $I_{DS}=-10A$		33		nC
Q_{gs}	Gate-Source Charge			5.3		
Q_{gd}	Gate-Drain Charge			8.6		

Notes:

- ①Pulse width limited by safe operating area.
- ②Calculated continuous current based on maximum allowable junction temperature.The package limitation current is -40A.
- ③When mounted on 1 inch square copper board, $t \leq 10\text{sec}$.
- ④Limited by $T_{J\max}$, Starting $T_J = 25^\circ\text{C}$, $I_{AS\max} = -16\text{A}$, $L = 0.5\text{mH}$, $V_{DD} = -15\text{V}$, $R_G = 25\Omega$, $V_{GS} = -4.5\text{V}$.Part not recommended for use above this value.100% Final Test at $I_{AS} = -8\text{A}$, $L = 0.5\text{mH}$.
- ⑤Pulse test;Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- ⑥Guaranteed by design, not subject to production testing.

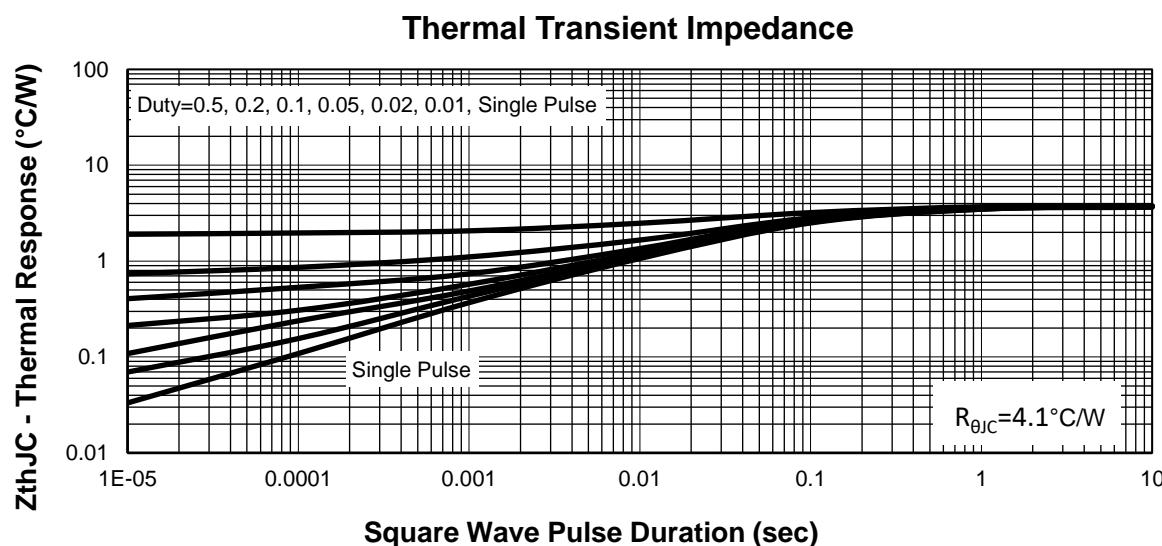
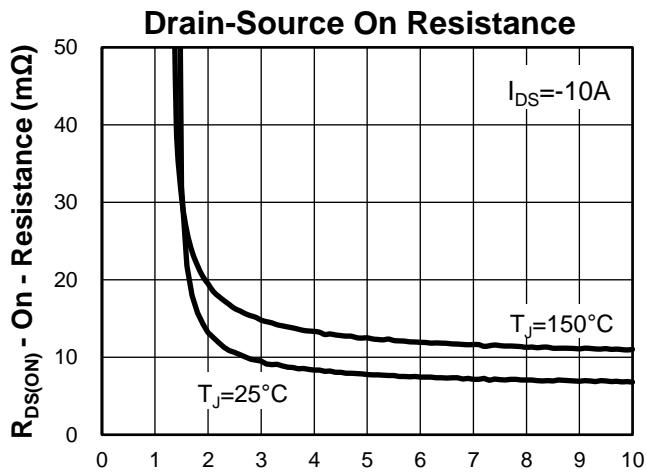
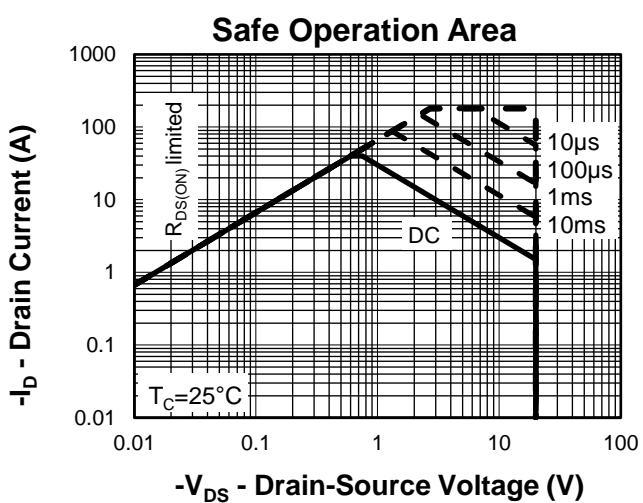
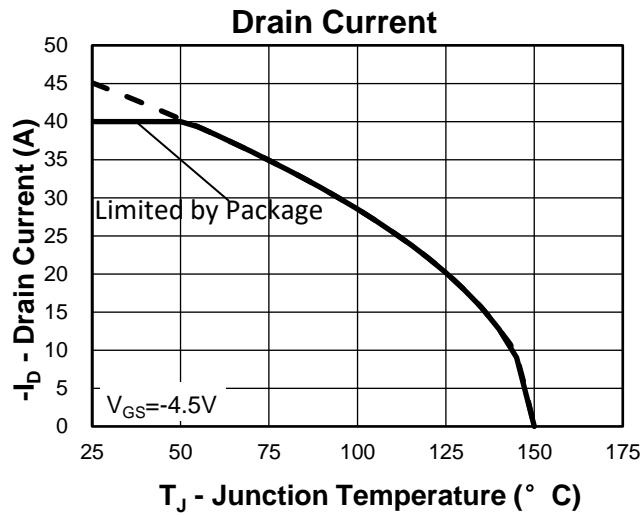
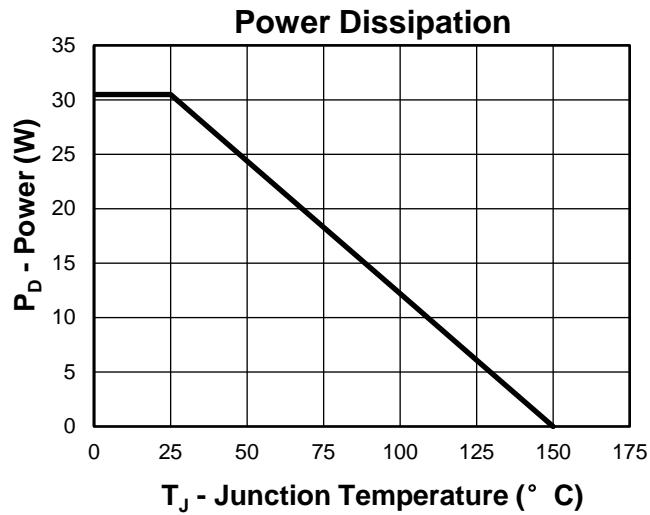
Ordering and Marking Information

Device	Package	Packaging	Quantity	Reel Size	Tape width
KS2317MA	PDFN3333	Tape&Reel	5000	13"	12mm

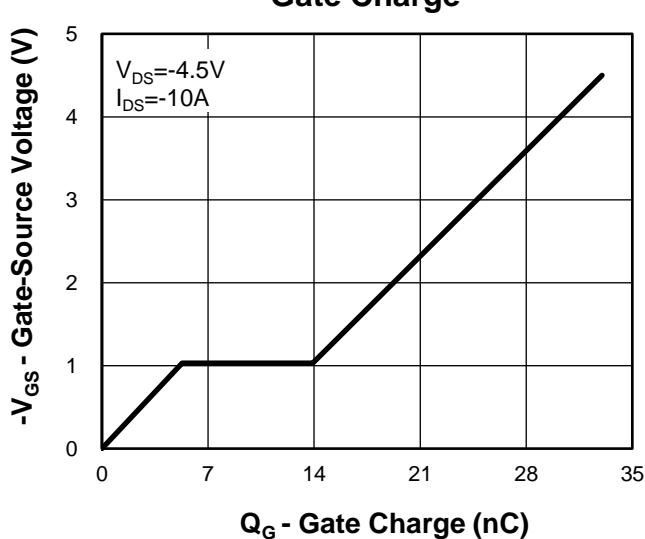
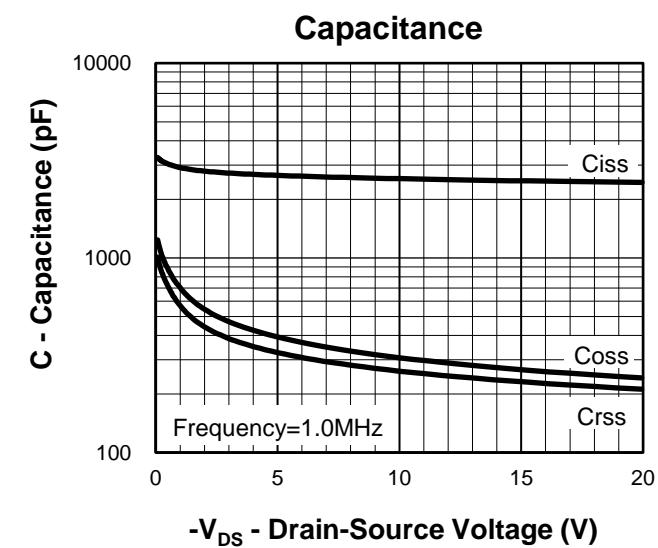
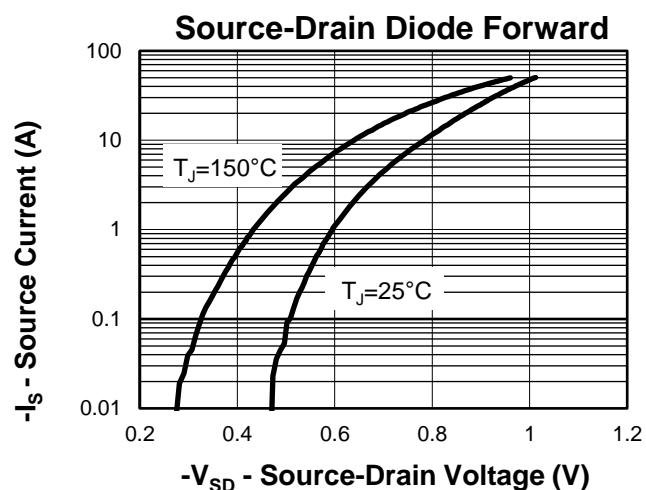
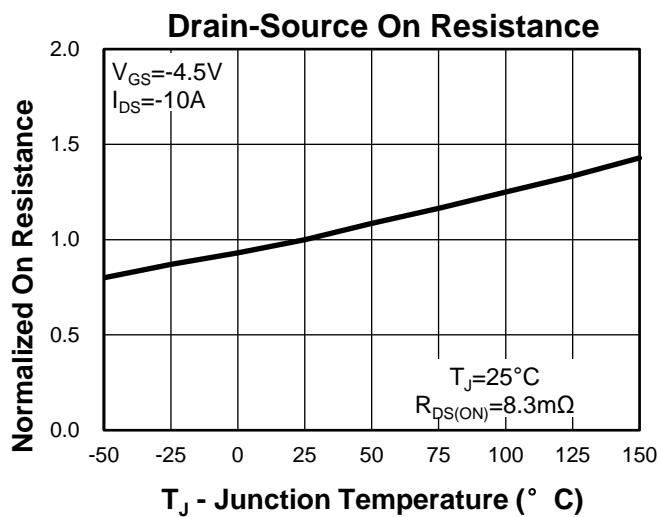
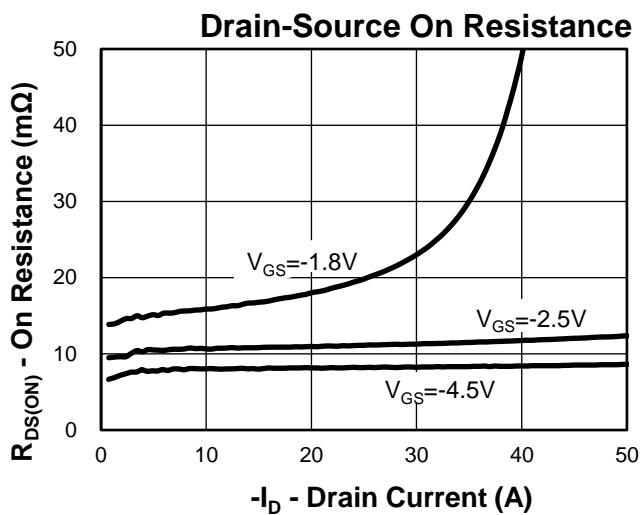
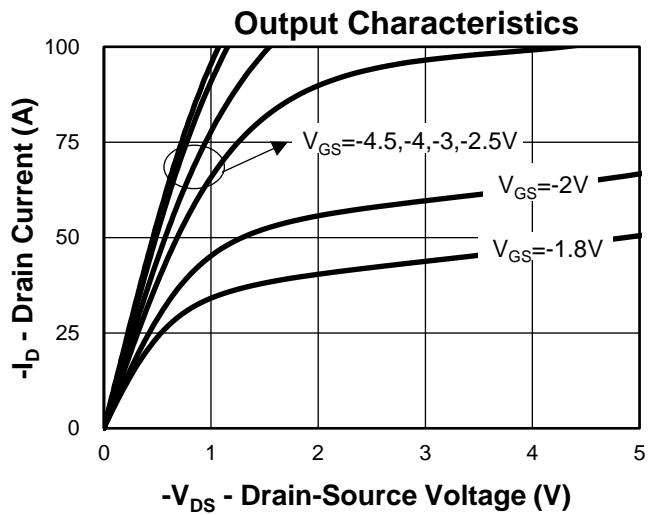


1st Line: Kwansemi Code(KS)
2nd Line: Part Number(2317)
3rd Line: Lot Number(YWWXXX)

Typical Characteristics

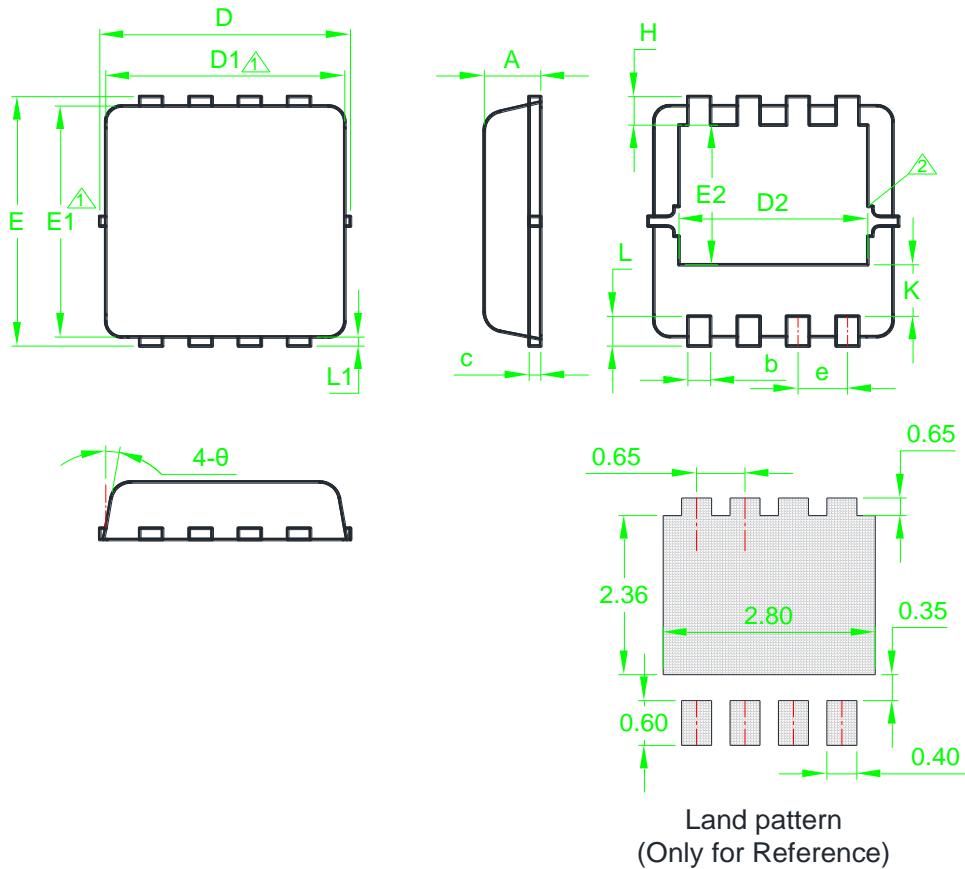


Typical Characteristics



Package Information

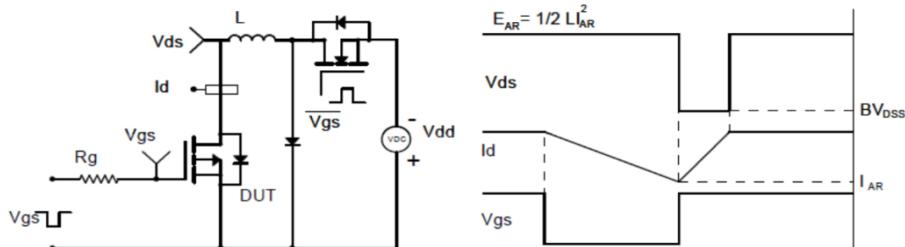
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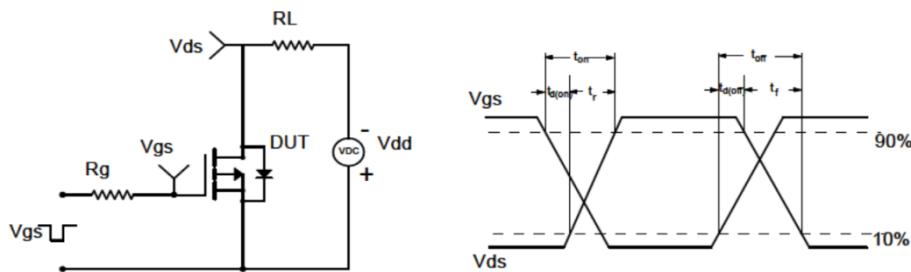
SYMBOL	MM			INCH			SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX		MIN	NOM	MAX	MIN	NOM	MAX
A	0.70	0.80	0.90	0.028	0.031	0.035	E2	1.40	*	1.95	0.055	*	0.077
b	0.25	0.30	0.35	0.010	0.012	0.014	e	0.65BSC			0.026BSC		
c	0.10	0.20	0.30	0.004	0.008	0.012	H	0.30	0.40	0.50	0.012	0.016	0.020
D	3.20	3.30	3.40	0.126	0.130	0.134	K	0.50	*	*	0.020	*	*
D1	3.00	3.10	3.20	0.118	0.122	0.126	L	0.30	0.40	0.50	0.012	0.016	0.020
D2	2.35	2.45	2.55	0.093	0.096	0.100	L1	0.15BSC			0.006BSC		
E	3.20	3.30	3.40	0.126	0.130	0.134	θ	6°	*	12°	6°	*	12°
E1	2.90	3.05	3.20	0.114	0.120	0.126							

- ① Dimensions D1 and E1 do not include mold flash protrusions or gate burrs.
 ② The size and shape of exposed pad are variable depending on mold.

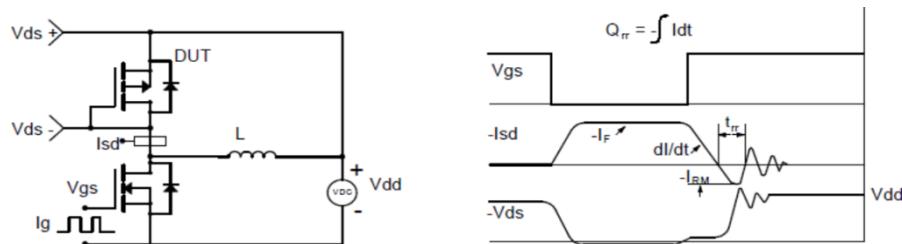
Avalanche Test Circuit and Waveforms



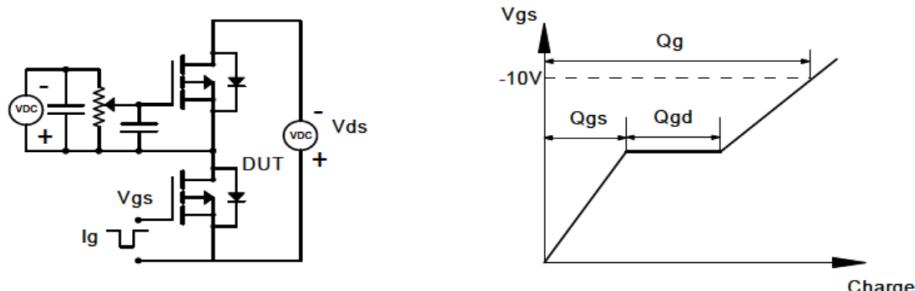
Switching Time Test Circuit and Waveforms



Diode Recovery Test Circuit and Waveforms



Gate Charge Test Circuit and Waveform



Customer Service

Kwansemi Semiconductor Co.,Ltd

Email:Sales@kwansemi.com

Web:www.kwansemi.com

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